



BYD Microelectronics Co., Ltd.

# BF92302N

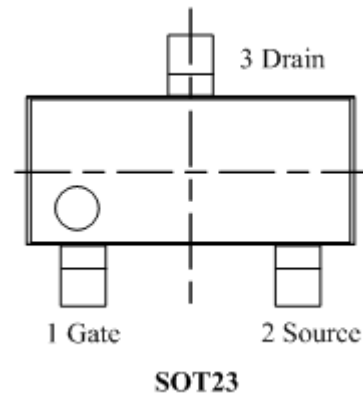
## 20V N-Channel MOSFET

### General Description

The BF92302N uses advanced trench technology to provide excellent  $R_{DS(on)}$  and low gate charge. This device is suitable for used as a load switch or in PWM applications.

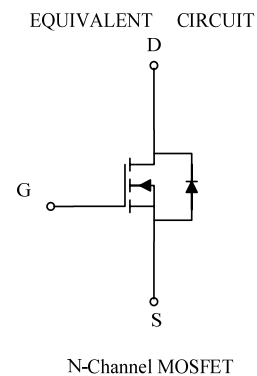
### Features

- $V_{DS}$  (V) = 20V
- $I_D$  = 3 A
- Low on-state resistance  
 $R_{DS(on)}$  = 50m $\Omega$  TYP.( $V_{GS}$  = 4.5V)  
 $R_{DS(on)}$  = 60m $\Omega$  TYP.( $V_{GS}$  = 2.5V)



### Absolute Maximum Ratings (Ta = 25°C)

Parameter	Symbol	Value	Unit
<b>N-MOSFET</b>			
Drain to Source Voltage	$V_{DSS}$	20	V
Gate to Source Voltage	$V_{GSS}$	$\pm 8$	V
Drain Current (DC)	$I_{D(DC)}$	3	A
Drain Current (pulse) <sup>a</sup>	$I_{D(pulse)}$	12	A
Maximun Power Dissipation <sup>a</sup>	$P_D$	1.3	W
Channel Temperature	$T_{ch}$	150	°C
Storage Temperature	$T_{stg}$	-55~+150	°C



**Note:** Mounted on FR4 Board of 1"x1".

**Caution:** These values must not be exceeded under any conditions.

### Ordering Information

- Part Number : BF92302N
- Package : SOT-23

Electrical Characteristics ( $T_A = 25^\circ\text{C}$ )

Symbol	Characteristics	Test Conditions	Min.	Typ.	Max.	Unit
$I_{DSS}$	Zero Gate Voltage Drain Current	$V_{DS} = 20V, V_{GS} = 0V$			1	$\mu\text{A}$
$I_{GSS}$	Gate Leakage Current	$V_{GS} = \pm 8V, V_{DS} = 0V$			$\pm 100$	nA
$V_{GSS(off)}$	Gate Cut-off Voltage	$V_{DS} = V_{GS}, I_D = 0.25\text{mA}$	0.65	0.95	1.2	V
$ y_{fs} $	Forward Transfer Admittance	$V_{DS} = 5V, I_D = 4A$		6.5		S
$R_{DS(on)1}$	Drain to Source On-state Resistance	$V_{GS} = 4.5V, I_D = 1.5A$		50	60	m $\Omega$
$R_{DS(on)2}$		$V_{GS} = 2.5V, I_D = 1.5A$		60	115	m $\Omega$
$C_{iss}$	Input Capacitance	$V_{GS} = 0V,$ $V_{DS} = 15V, f = 1.0\text{MHz}$		942		pF
$C_{oss}$	Output Capacitance			193.8		pF
$C_{rss}$	Reverse Transfer Capacitance			19.7		pF
$t_{d(on)}$	Turn-on Delay Time	$V_{DD} = 10V, I_D = 1.5A,$ $V_{GS} = 4.5V, R_G = 4.7\Omega$		9.24		ns
$t_r$	Rise Time			11.34		ns
$t_{d(off)}$	Turn-off Delay Time			19.93		ns
$t_f$	Fall Time			4.6		ns
$Q_G$	Total Gate Charge	$V_{DD} = 10V, I_D = 1.5A,$ $V_{GS} = 4.5V, R_G = 10\Omega$		7		nC
$Q_{GS}$	Gate to Source Charge			1		nC
$Q_{GD}$	Gate to Drain Charge			1.4		nC
$V_{SD}$	Drain-Source Diode Forward Voltage	$I_s = 0.94A, V_{GS} = 0V$			1.2	V

Typical characteristics (25°C unless noted)

Figure 1 Output Characteristics

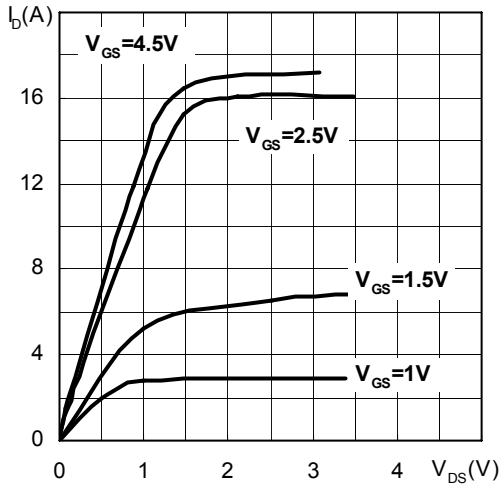


Figure 2 Transfer Characteristics

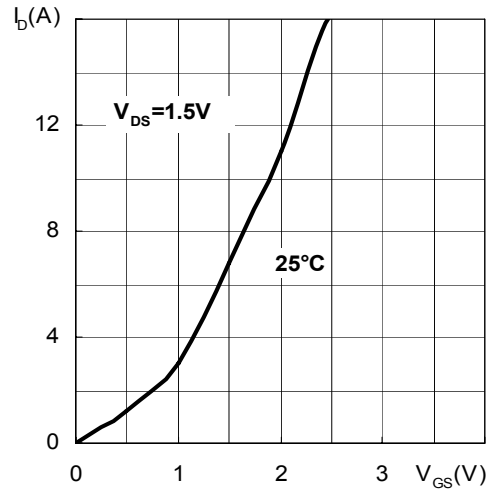


Figure 3 On Resistance VS Temperature

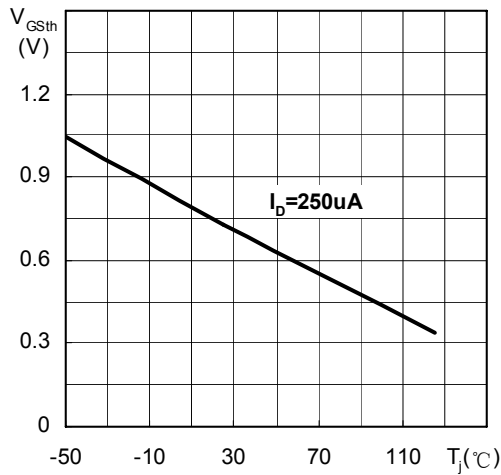


Figure 4 Normalized  $BV_{DSS}$  vs. Temperature

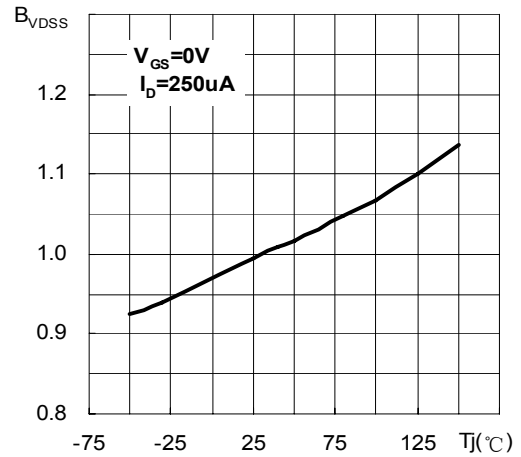


Figure 5  $R_{DS(on)}$  vs. Temperature

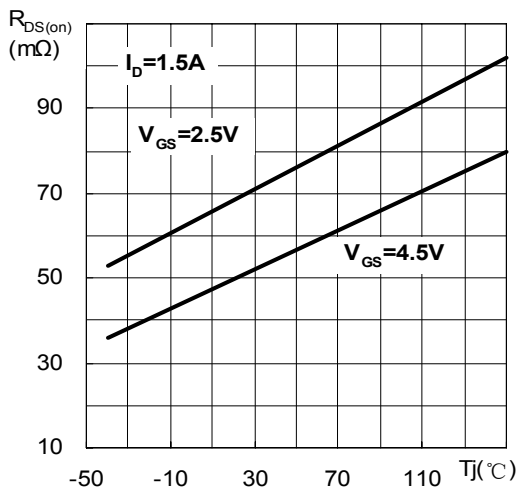


Figure 6  $I_{GSS}$  vs. Temperature

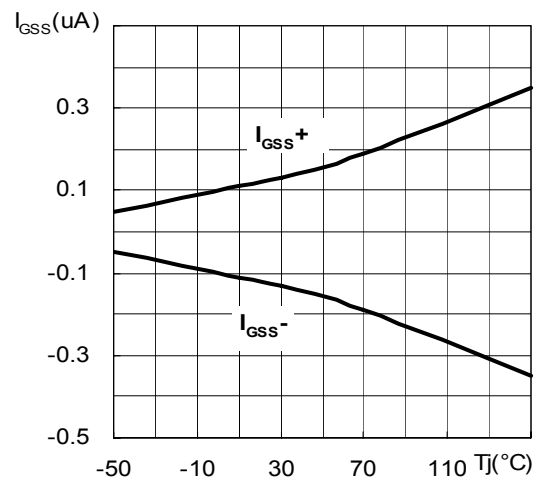


Figure 7 Capacitance

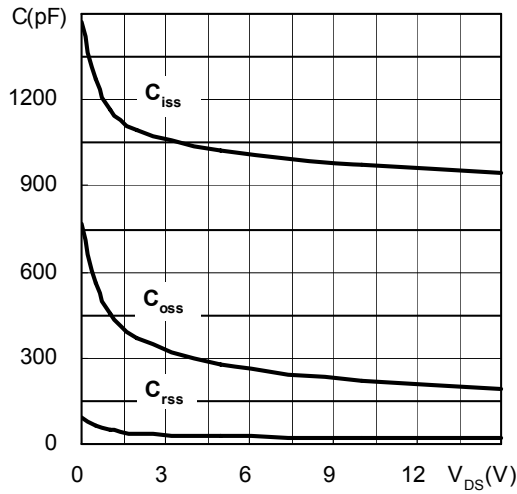


Figure 8 Gate Charge

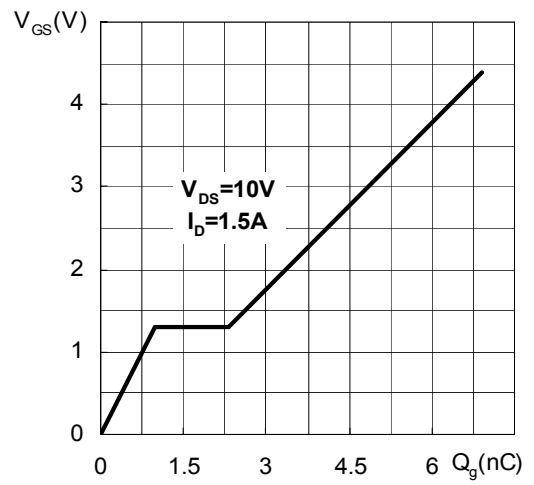


Figure 9 Safe Operating Area

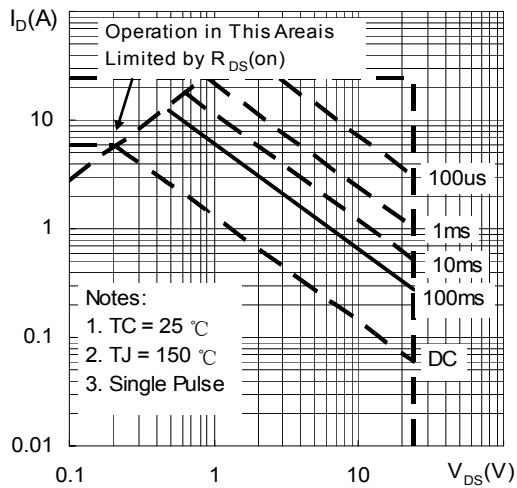


Figure 10 Maximum I\_DSS Vs. Case Temperature

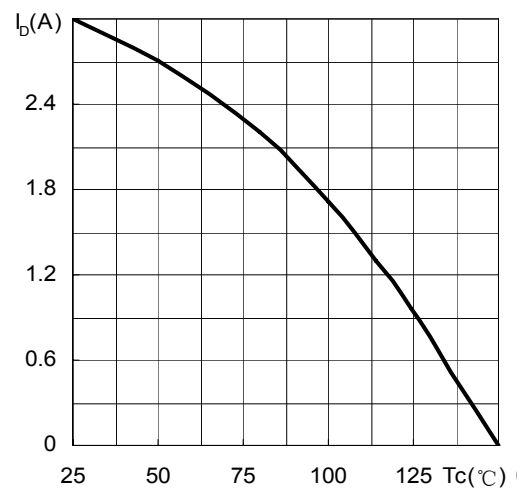


Figure 11 On Resistance VS Gate to Source Voltage

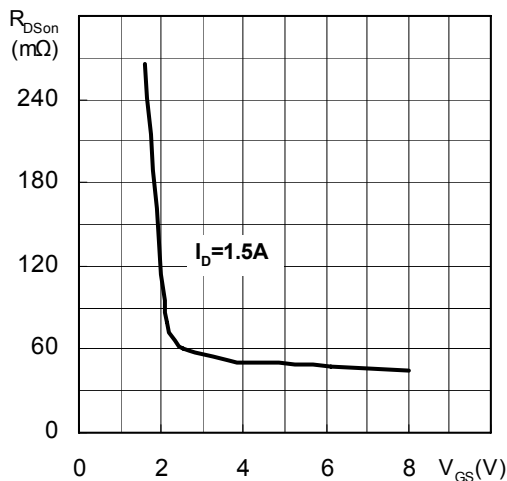
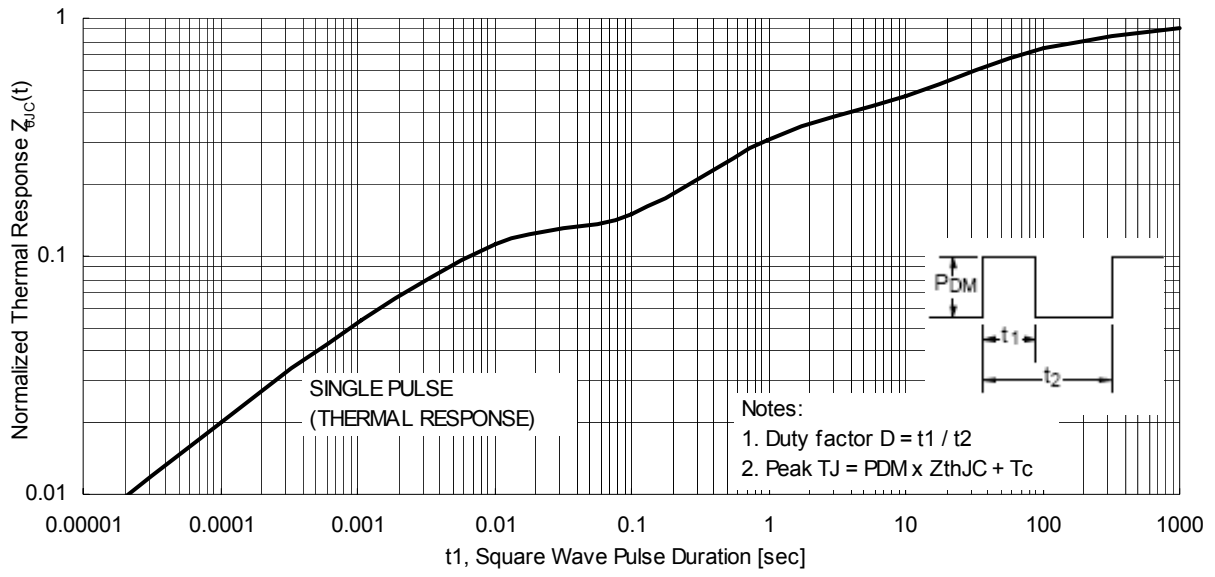
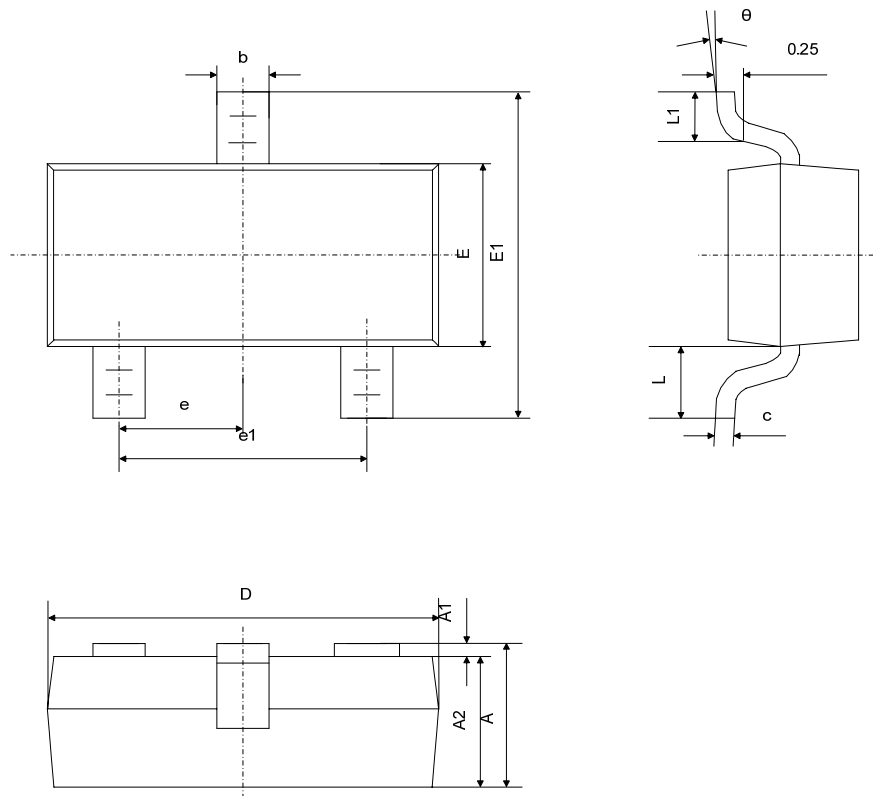


Figure 12 Normalized Maximum Transient Thermal Impedance



**Package Drawing**


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
<b>A</b>	0.889	1.150	0.035	0.045
<b>A1</b>	0.000	0.100	0.000	0.004
<b>A2</b>	0.900	1.050	0.035	0.041
<b>b</b>	0.300	0.500	0.012	0.020
<b>c</b>	0.080	0.150	0.003	0.006
<b>D</b>	2.800	3.000	0.110	0.118
<b>E</b>	1.200	1.400	0.047	0.055
<b>E1</b>	2.250	2.550	0.089	0.100
<b>e</b>	0.950TYP		0.037TYP	
<b>e1</b>	0.800	2.000	0.071	0.079
<b>L</b>	0.550REF		0.022REF	
<b>L1</b>	0.300	0.500	0.012	0.020
<b>θ</b>	0°	8°	0°	6°

**Note:**

1. Dimension D does not include mold flash, protrusions or gate burrs. Mold flash, protrusions or gate burrs shall not exceed 0.10mm per side.
2. Dimension E1 does not include inter-lead flash or protrusion. Inter-lead flash or protrusion shall not exceed 0.1mm per side.



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